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INTERNATIONAL STANDARD



Printed electronic**s** Feh STANDARD PREVIEW Part 301-1: Equipment – Contact printing – Rigid master – Measurement method of plate master external dimension

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INTERNATIONAL ELECTROTECHNICAL COMMISSION

PRINTED ELECTRONICS -

Part 301-1: Equipment – Contact printing – Rigid master – Measurement method of plate master external dimension

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International Standard IEC 62903-1 has been prepared by IEC technical committee:119: Printed electronics.

The text of this standard is based on the following documents:

FDIS	Report on voting
119/152/FDIS	119/162/RVD

Full information on the voting for the approval of this International Standard can be found in the report on voting indicated in the above table.

This document has been drafted in accordance with the ISO/IEC Directives, Part 2.

A list of all parts in the IEC 62899 series, published under the general title *Printed electronics*, can be found on the IEC website.

The committee has decided that the contents of this document will remain unchanged until the stability date indicated on the IEC website under "http://webstore.iec.ch" in the data related to the specific document. At this date, the document will be

- reconfirmed,
- withdrawn,
- replaced by a revised edition, or
- amended.

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INTRODUCTION

When dissecting the term "printed electronics", it can be easily understood that this industry involves electronic devices and products that are made using some kind of printing technique. Printing methods have been widely used in textile and paper type substrates for centuries. In the past, the advent of mass producible printouts has brought huge impacts on how knowledge is stored, transferred and reproduced. At this current stage of technological development, printing on either rigid or flexible substrates is considered to supplement or replace traditional electronic device manufacturing processes. The difference between media printing and printed electronics stems from the fact that media print is used to convey information for humans to process using their eyes while printed electronics requires machines to process electronic information; the level of required resolution and functionality makes the difference. Some of the widely used functional materials for printed electronics are though not limited to: nano- or micro-size metal particles, semiconductive polymers, and dielectric materials. Due to the available and required readout resolution, small feature sizes below 20 µm need to be printed. Layer thickness and registration accuracy of printed products are closely related to the quality control of electronic devices and ink materials require a high level of quality. Overall, printing tolerance is much smaller in printed electronics.

There are two main categories in the printing process for the printed electronics. One is a non-contact printing process, such as inkjet printing and electrostatic discharge (ESD) printing process. The other is a contact printing process such as gravure printing, gravure offset printing, reverse offset printing and screen printing. This document provides a proposal for measuring and assessing the printing master, therefore the scope is limited to the printing process using the printing master. ANDARD PREVIEW

The quality of the printing master is important because the ink is transferred from the printing master to the substrate directly in these processes, which means that the quality of the results of the printed circuit depends on the quality of the printing master. For a mass production of the printed electronic devices, many companies such as device manufacturers, printing master manufacturing and printing master manufacturing equipment vendors are related to manufacturing and they would be using the printing master and the standardized measurement and assessment methods.

PRINTED ELECTRONICS –

Part 301-1: Equipment – Contact printing – Rigid master – Measurement method of plate master external dimension

1 Scope

This part of IEC 62899 defines measurement terms and methods related to the external dimension of a rigid plate master.

Measurement terms include geometrical size such as edge length, edge squareness, edge straightness and thickness, flatness of plate master substrates, and surface roughness of plate master.

2 Normative references

There are no normative references in this document.

3 Terms and definitions STANDARD PREVIEW

For the purposes of this document, the following terms and definitions apply.

ISO and IEC maintain terminological<u>idatabases1for0us</u>e in standardization at the following addresses: https://standards.iteh.ai/catalog/standards/sist/d7517c60-af61-4434-86e1-

- IEC Electropedia: available at http://www.electropedia.org/
- ISO Online browsing platform: available at http://www.iso.org/obp

3.1

plate master

device that carries the image to be printed

Note 1 to entry: The image on the plate may be raised above the surface (relief) or may be carved into the surface.

3.2

geometrical definition of plate master

definition which is needed in order to determine the shape and size of the plate

3.3

orientation corner

asymmetric corner specified for the purpose of mechanical orientation and the operator's visual confirmation of plate orientation

Note 1 to entry: This term is introduced graphically in Figure 1.



- 8 -

Figure 1 – Illustration of the terms defined for measuring the geometrical size of a plate master

3.4 machine direction **D PREVIEW** MD Гeh S direction in which the stock flows standards.iteh.ai) Note 1 to entry: It can also mean circumferential direction of a roll of substrate. IEC 62899-301-1:2017 3.5 https://standards.iteh.ai/catalog/standards/sist/d7517c60-af61-4434-86e1-CD

3ff251dd9fee/iec-62899-301-1-2017

cross direction

direction at right angles to the machine direction of a substrate

3.6

reference edges

two edges adjacent to the orientation corner which are used for referencing the position of the plate master

Note 1 to entry: This term is introduced graphically in Figure 1.

3.7

MD reference edge

reference edge parallel with the MD

Note 1 to entry: This term is introduced graphically in Figure 1.

3.8 **CD** reference edge

reference edge parallel with the CD

Note 1 to entry: This term is introduced graphically in Figure 1.

3.9

edge length

length and width of edges in a rectangular plate master

Note 1 to entry: This term is introduced graphically in Figure 1.

Note 2 to entry: L_{MD} and L_{CD} are the edge length of the MD reference edge and CD reference edge, respectively.

3.10

edge squareness

angular variation of MD reference edge relative to straight lines drawn between the ends of, and perpendicular to, the CD reference edge of the plate master

Note 1 to entry: This term is introduced graphically in Figure 1.

3.11 edge straightness

St

deviation of an edge relative to a straight line

3.12

reference plane

user-defined flat plane approximating the front surface of a plate master and containing a coordinate system

Note 1 to entry: The same definition is applied for the measurement of flatness and surface roughness.

3.13

thickness of the plate master

relative distance of the plate master from the bottom surface to the front surface at the center position in the normal direction of the reference plane

Note 1 to entry: This term is introduced graphically in Figure 10 PREVIEW

3.14

flatness of plate master subst(ateandards.iteh.ai)

thickness variation of the entire plate master front surface relative to a reference plane when the substrate back surface is constrained against an ideally flat surface

https://standards.iteh.ai/catalog/standards/sist/d7517c60-af61-4434-86e1-Note 1 to entry: This term is introduced graphically in Eigure 2301-1-2017



IFC

Figure 2 – Graphical illustration of flatness [1]¹

3.14.1

flatness cut-off wavelength

wavelength at which the attenuation ratio of its amplitude becomes a standard value when the traced profile is passed through the filter which eliminates the roughness element

3.14.2

profile

positive and negative vertical deviations measured from the reference plane

¹ Numbers in square brackets refer to the Bibliography.